Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/510,642	INOUE, AKIHISA
Examiner	Art Unit
John P. Sheehan	1742

	SEAR	SEARCHED		
Class	Subclass	Date	Examiner	
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TERFERENCE SEARCHED			
Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST see printout	9/30/2005	JS		
PALM inventor name search	9/30/2005	JS		
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